

SAMSUNG SEMICONDUCTOR INC

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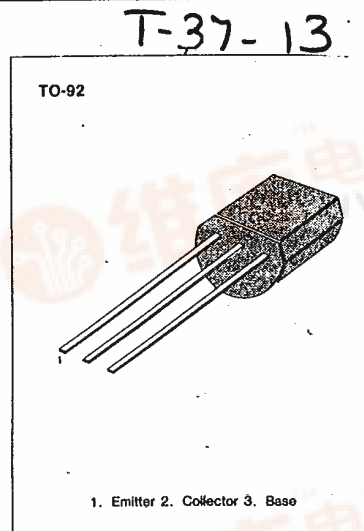
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KSR2012**PNP EPITAXIAL SILICON TRANSISTOR****SWITCHING APPLICATION** (Bias Resistor Built In)

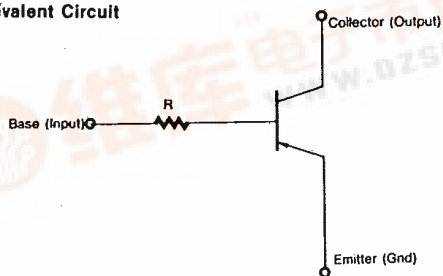
- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built In bias Resistor ($R=47K\Omega$)
- Complement to KSR1012

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-40	V
Collector-Emitter Voltage	V_{CE0}	-40	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS** ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -100\mu\text{A}$, $I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1\text{mA}$, $I_B = 0$	-40			V
Collector Cutoff Current	I_{C0}	$V_{CB} = -30\text{V}$, $I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -1\text{mA}$	100		600	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}$, $I_B = -1\text{mA}$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1\text{MHz}$		5.5		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -10\text{V}$, $I_C = -5\text{mA}$		200		MHz
Input Resistor	R		32	47	62	$K\Omega$

Equivalent Circuit

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